3.1 Introduction When a p-type and an n-type semiconductor are brought together in close contact, the When a p-type of the interface where the two types meet is called the p-n junction.

boundary of the interface where the two types meet is called the p-n junction.

A useful p-n junction cannot be constructed merely by welding a piece of p-type A useful p a discontinuity across the junction. There are two principles a grain boundary i.e., a discontinuity across the junction. There are two principal techniques of fabricating a p-n junction: (i) grown junction and (ii) fused junction, into the details of which we shall not enter. The p-n junctions are created by doping one side of a of which single crystal semiconductor with acceptors and the other side with donors. A p-n single constant is thus a two-terminal device and is known as a junction diode. Most of the  $_{\text{semiconductor}}$  devices contain one or more p-n junctions because of its effective role as a control element. So, the p-n junctions are elementary 'building blocks' of almost all the semiconductor devices like transistors, LEDs, ICs, solar cells etc.

# 3.2 Unbiased p-n junction

In a p-type semiconductor, holes are the majority carriers and in an n-type semiconductor electrons are the majority carriers. When a p-n junction is formed (Fig 3.1(a)), electrons from n-region diffuse into p-region and holes from p-region diffuse into n-region due to the difference in carrier concentration. During the process of diffusion, the electrons recombine with the holes in the p-side after crossing the junction, leaving behind the positively charged immobile donor ions in n-region. The hole in their turn cross the junction to recombine with the electrons in the n-region, leaving behind the negatively charged immobile acceptor ions in the p-region.

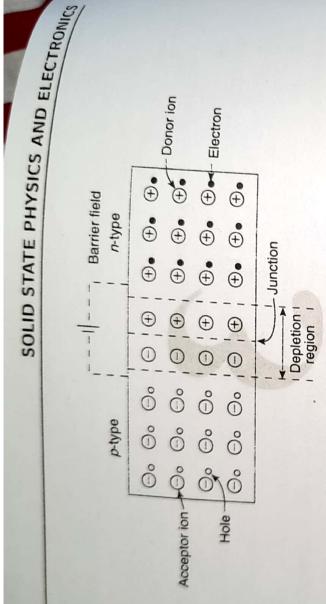


Fig. 3.1 Schematic diagram of a p-n junction

As a consequence of the diffusion and recombination, non-neutralized ions are left in the neighbourhood of the junction. Since the region near the junction becomes deprived of the mobile charge carriers (electrons or holes) and contains only the immobile ions, it is called the depletion region or the space charge region. It is also called transition region. The thickness of depletion region is  $\sim 10^{-6}$  m. The non-neutralized positive and negative charges produce an electric field across the junction directed from n-side to the p-side. This field is called potential barrier or barrier field which opposes However, it is to be noted that the field helps the minority carriers to move across the junction and a very small amount of current flows. The potential barrier  $V_b$  acts internal barrier field is just sufficient to prevent diffusion of majority charge carriers. as a fictitious battery connected respectively with its positive terminal to n-side and negative terminal to p-side. The circuit symbol of a p-n junction diode is shown in Fig. 3.2 where the arrowhead is in the direction of current flow when the p-side and the n-side are connected respectively to the positive and negative pole of a battery. In equilibrium, diffusion of electrons and holes through the junction. further

D why we cannot measure doctor from barrier potential of a p-n'yinction. p : >1 K n · →e · → holes 12000 0 0 0°0 ( immobile ovely charged acceptoris (1) immobile +vely charged do nor low - AD Karrier potential. reference D-) depletionregion Vb=-(Edx · barrier potential exists across the depletron region I not across the diode, so the region of existence of electric field lines is limited to the depletion region only wolfmeter / multimeter is connected a cross The terminat of pln junctions. The unbiased pln regions Letween withwiter probe & depletion region acts as insulator & prevents field lines to reach the voltmeter probes. To measure potential, slightent of current should move within the weltmeter, If the In the biosed unblased p-njurction the ohmic contact forming p-n diodro at the suni conductor metal junction which hides the barrier putential drop.

diodro at the sensi corductor metal junction while wides the barrier prientral emp Diode current I vietage masurement diode Characteristics ourse i dealized come SI forward resistance anident case (Rd=0) I = 10 5 = 0"

Vd = Voltage chop at D 100 D will behave as R= as or open circuit - · Vd = 5 V & Vat 10.0 = 0

### 3.7 Characteristics of a Zener diode

A Zener diode exhibits almost the same properties as that of a p-n junction diode. It is a Zener diode is shown in Fig. 3.11.

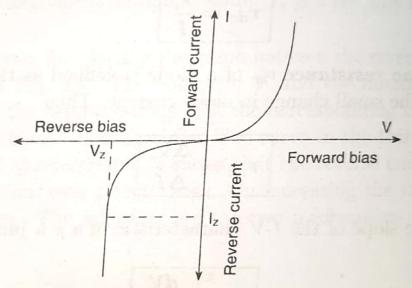


Fig. 3.11 I-V characteristics of a Zener diode

The forward biased characteristic is similar to that of an ordinary p-n junction diode. Under reverse bias, the I-V characteristic is similar to an ordinary p-n junction diode up to the breakdown voltage. In Zener diodes, the doping is controlled in such a way that the breakdown voltage is sharp and distinct. Beyond the breakdown voltage, the reverse current increases sharply to high value which indicates that the voltage across the diode is almost independent of the diode current in this region. This breakdown voltage is known as Zener voltage  $V_z$  and the corresponding current is Zener current  $I_z$ . Clearly,  $V_z$  remains constant even when  $I_z$  increases rapidly. This makes a Zener diode extremely useful as a voltage regulator device or reference diode.

chapter 3 The P-IN Junction Zener diode is prepared as highly doped p-type and n-type semiconductor rating is so high that it is not damaged by the large reverse North power rating are used as voltage regulator. The circular reverse reverse research to the large reverse reverse research to the large reverse reverse research to the large reverse rever Moreover, Zener rating is so high that it is not damaged by the large reverse current.

Noreover, Tener rating is so high that it is not damaged by the large reverse current. The circuit diagram of a simple repulsion is shown in Fig. 3.12. More power rate used as voltage regulator. The circuit diagram of a simple Zener diodes are used in Fig. 3.12. 50, Zener allator is shown in Fig. 3.12.

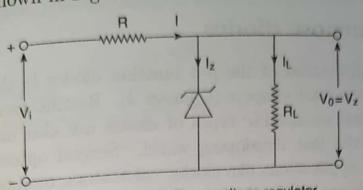


Fig. 3.12 Simple Zener voltage regulator

The unregulated dc supply voltage  $V_i$  (>  $V_z$ ) and the series resistance R are so chosen that the diode operates in the reverse breakdown region. The Zener diode chosen when the land registeries  $R_z$  across the load resistance  $R_L$ , although the keeps a voltage  $V_i$  or the load resistance  $R_L$ , may vary over a wide range.

Let I and  $I_L$  be the supply current and the load current respectively. From Fig. 3.12,

we get, by applying the KCL and the KVL

$$I = I_z + I_L (3.8.1)$$
(3.8.2)

$$I = I_z + I_z$$

$$V_z = V_i - IR$$

$$(3.8.2)$$

$$(3.8.3)$$

$$V_z = V_i - IR$$

$$V_z = V_0 = I_L R_L$$
(3.8.3)
$$V_z = V_0 = I_L R_L$$

The output voltage  $V_0$  may be varied (i) by varying the load resistance  $R_L$  and (ii) by variation of the input voltage  $V_i$ .

(A) Load regulation—In this case, the supply voltage  $V_i$  is kept constant and the load current  $I_L$  is changed by changing  $R_L$ . For an ideal case,  $V_z$  is constant. So,  $\Delta V_z = 0$  and  $\Delta V_i = 0$ .

$$\Delta I = 0$$

i.e., 
$$\Delta I_z + \Delta I_L = 0$$
, using (3.8.1)  
or,  $\Delta I_z = -\Delta I_L$  (3.8.4)

Thus, if the load resistance is increased, keeping the supply voltage constant, the load current decreases with an equal increase in Zener current so that the output remains constant at  $V_z$ .

(B) Line regulation—When the load resistance  $R_L$  is kept fixed and the supply voltage  $V_i$  is varied, we get from (3.8.2)

$$\Delta V_i = \Delta I \cdot R \tag{3.8.5}$$

since  $\Delta V_z = \Delta V_0 = 0$  and  $I_L$  is constant. From (3.8.1), therefore, (3.8.6)

$$\Delta I = \Delta I_z$$

## 3.9.1 Light Emitting Diode (LED)

Light emitting diode (abbreviated as LED) is a special type semiconducting pn junction diode which emits light under forward biased condition.

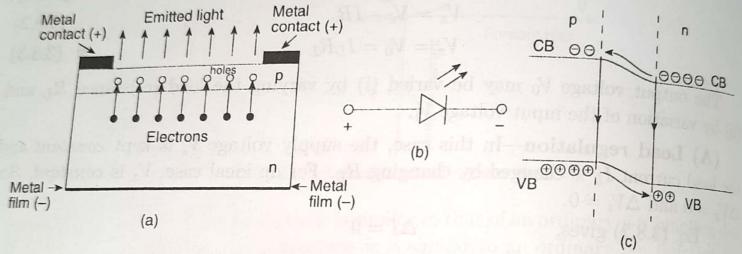


Fig. 3.13 (a) Construction of LED (b) Symbol of LED (c) Electron-hole recombination and emission of light

Construction—The construction of a typical LED can be followed from Fig. 3.13(a). First, one *n*-type layer of gallium arsenide (GaAs) or gallium arsenide phosphide (GaAsP) or some other suitable semiconducting material is grown on a substrate. Then, a *p*-type layer of very small thickness is deposited onto it by diffusion so that ght energy may emit from the depletion region after travelling a very short distance. The metal anode connection is made at the *p*-layer so as to allow more surface area or light emission and the cathode connection is made at the bottom of the substrate pated with metal film. Most of the LEDs contain a domed lens that gathers and tensifies light. Fig. 3.13(b) shows the symbol of a LED.

Principle of working—The principle underlying the operation of a LED is the ission of radiation due to recombination of holes and electrons. When a p-n junction

Chapter 3 The P-N Junction biased, the barrier height decreases and electrons from the *n*-side and the forward the *p*-side move towards the narrow depleted region. This result is from the *p*-side move towards the electrons with the *p*-side move towards the electrons wi biased, the move towards the narrow depleted region. This results in the poles from the process and electrons from the n-side and the holes from the process are depleted region. This results in the holes from the process are depleted region. boles from the P-side and the lectrons make transition from conduction band lelectron-hole recombination. Since the electrons make transition from conduction band electron-hole recombination this process, energy is released as a photon of frequence band during this process, energy is released as a photon of frequence. hole recombined this process, energy is released as a photon of frequency  $\nu$  given to valence band during this process.

$$E_g = h\nu$$

where  $E_g$  = band gap energy. The corresponding wavelength  $\lambda$  is given by

$$\lambda = \frac{hc}{E_g} \quad (\because \ \nu = c/\lambda)$$

The downward transition of electrons from the conduction band to the valence band and subsequent emission of photons due to recombination is shown in Fig. 3.13(c). The intensity of emitted light depends on the number of photons which in turn depends on the number of recombination that occurs.

For GaAsP, the band gap energy  $E_g = 1.9 \,\mathrm{eV}$ . So we have

the band gap energy 
$$E_g = 1.9 \,\mathrm{eV}$$
. So we have the band gap energy  $E_g = 1.9 \,\mathrm{eV}$ . So we have  $\lambda = \frac{hc}{E_g} = \frac{6.62 \times 10^{-34} \times 3 \times 10^8}{1.9 \times 1.6 \times 10^{-19}} \,\mathrm{m} = 6533 \,\mathrm{Å}$  (reddish) are respectively. The applications of LED are respectively.

Uses and advantages of LED—The applications of LED are rather too many.

- 1. LEDs are mainly used in signal lamps and display devices, in digital watches, in Some of the uses are as under: TV remotes, in calculators and multimeters, in telephone switchboards, etc.
  - 2. The infrared LEDs are used in optical fibre communication and alarm systems
  - 3. LED can also be used as a laser, known as Injection Junction Laser.

Advantages—LEDs have the following advantages over the traditional lamps with

- 1. LEDs consume relatively much smaller power for their operation. filaments.
  - 2. They have also quite long life span ( $\sim 100{,}000~{\rm hours}$ )
  - 3. They are very fast in action, small in size and cheap in price.
  - 4. They are available to emit light of all colours.

The first solar cells were developed in USA in 1954 and were made of silicon. Silicon. Silicon. cells are the only ones, even to-day, that enjoy the commercial status.

s are the only ones, even to-day, that sare the ones, the sare the one Construction—A solar cell is basicany and Construction diode made of silicon. Fig. 3.14(a) shows schematically the constructional details of a typical solar cell

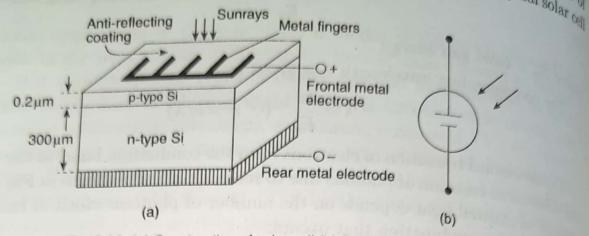


Fig. 3.14 (a) Construction of solar cell (b) Symbol of solar cell

and Fig. 3.14(b) gives its symbolic representation. The upper electrode of the cell is in the form of a ring or a grid with fingers so that sunlight may easily pass through it. To prevent the loss of light by reflection, the upper surface is coated by an anti-reflecting layer. The p-layer of the junction diode is much thinner compared to the n-layer for an easy diffusion of majority carriers before recombination. The lower electrode (metal) completely covers the surface. Both the p and the n-regions are heavily doped to obtain a large amount of photovoltage.

Principle of working—The schematic diagram of a p-n junction solar cell with a load resistance  $R_L$  is shown in Fig. 3.15(a). Since the band gap for silicon is 1.1.eV, the photons of sunlight incident on the diode, if absorbed, can produce electron-hole pairs in both the p and n-side of the junction. The electrons and holes produced near the depletion layer reach finally the depletion region W by diffusion and are separated by

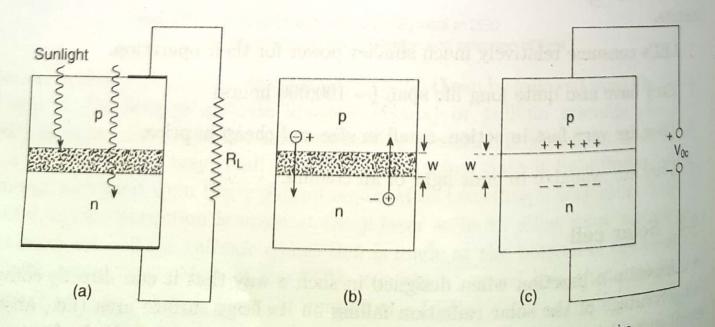


Fig. 3.15 (a) Incident photons (b) absorption of photons and creation of e-h pairs (c) deposition of charges

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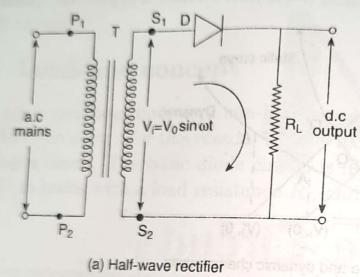
Chapter 3 The P-N Junction strong barrier field that exists there. The electrons in the p-side and the holes in the n-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) and are described as p-swept away in the depletion region (Fig. 3.15(b)) are described as p-swept away are d strong barrier away in the depletion region (Fig. 3.15(b)) and are deposited at the edge side are swept away in layer producing an open circuit voltage  $V_{cc}(\text{Fig. 3.15(c)})$  $_{\rm side}$  are swept and are deposited at the edge  $_{\rm side}$  depletion layer producing an open circuit voltage  $V_{\rm oc}({\rm Fig.~3.15(c)})$ . When a load of the diagram a current flows through the load so long the diagram. of the depicted, a current flows through the load so long the diode is exposed to sunlight. In a circuit voltage is quite low ( $\sim 0.5\,\mathrm{V}$ ) and the maximum of the contract of the sunlight. s connected, the voltage is quite low ( $\sim 0.5\,\mathrm{V}$ ) and the maximum value of current i.e., the open circuit current is  $\sim 10^{-3}\,\mathrm{A}$ . So, for practical applications The open circuit current is  $\sim 10^{-3}$  A. So, for practical applications, a large number of the short circuit current in series and parallel to produce the combined in series and parallel to produce the series are series and parallel to produce the series and parallel to produce the series are series are series and parallel to produce the series are series are series and parallel to produce the series are ser he short energy to be combined in series and parallel to produce appreciable amount of olar cents. Such a combination of solar cells is known as a solar panel.

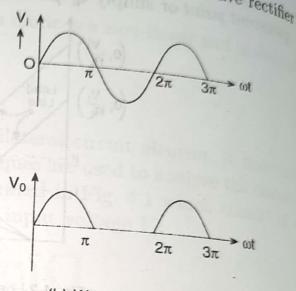
Uses of solar cells—Solar cells have already a number of applications and they e on the increase. Some are enumerated below.

- 1. Solar cells are extensively used to recharge the storage batteries in satellites and communication equipments.
- 2. They are used to power watches and calculators.
- 3. They are also capable of detecting very low level of light intensity.
- 4. They are being increasingly used to provide domestic and commercial electricity in an eco-friendly way, particularly in areas where the sunshine is plentiful.



wave, it is called half-wave rectifier. The basic circuit diagram of a half-wave rectifier is illustrated in Fig. 4.3(a).





(b) Wave forms of the input and output voltages

Fig. 4.3

An alternating input voltage if fed to the primary  $P_1P_2$  of a transformer T, which may be a step up or a step down transformer, an alternating voltage is induced at the secondary  $S_1S_2$  due to mutual induction. The p-n junction diode D is connected across the secondary in series with a load resistance  $R_L$ . When the D is forward biased i.e.,  $S_1$  is positive and  $S_2$  is negative, the current flows through the load resistance  $R_L$  in the direction of arrows (Fig. 4.3(a)) and an output voltage is obtained across the load. During the next half cycle,  $S_1$  becomes negative and  $S_2$  positive so that the diode is reverse biased. In this case, no output current and hence no output voltage, is obtained. Fig. 4.3(b) shows the a.c input and the unidirectional pulsating output

### Full-wave rectifier 1 for 11

